ICODE ILT Rev. 3.3 — 15 October 2019 234333

Product data sheet COMPANY PUBLIC

1 General description

The ISO 18000-3 mode 3/EPC Class-1 HF standard allows the commercialized provision of mass adoption of HF RFID technology for passive smart tags and labels. Main fields of applications are supply chain management and logistics for worldwide use.

The ICODE ILT is a dedicated chip for passive, intelligent tags and labels supporting the ISO 18000-3 mode 3 RFID standard. It is especially suited for applications where reliable identification and high anti-collision rates are required.

The ICODE ILT is a product out of the NXP Semiconductors ICODE product family. The entire ICODE product family offers anti-collision functionality. This allows a reader to simultaneously operate multiple labels/tags within its antenna field. A ICODE ILT based label/tag requires no external power supply.

Its contactless interface generates the power supply via the antenna circuit by inductive energy transmission from the interrogator (reader), while the system clock is extracted from the magnetic field. Data transmitted from interrogator to label/tag is demodulated by the interface, and it also modulates the interrogator's magnetic field for data transmission from label/tag to interrogator. A label/tag can be operated without the need for line of sight or battery, as long as it is connected to a dedicated antenna for the targeted frequency range. When the label/tag is within the interrogator's operating range, the high-speed wireless interface allows data transmission in both directions.



2 Features and benefits

2.1 Key features

- Up to 240-bit of EPC memory
- 96-bit tag identifier (TID) including 48-bit unique serial number
- EAS (Electronic Article Surveillance) functionality
- Recommissioning feature (privacy) with 32-bit kill password
- · 32-bit access password to allow a transition into the secured state
- Long read/write ranges due to extremely low-power design
- Reliable operation of multiple tags due to advanced anti-collision (up to 800 tags/s)
- Fast initialization (write EPC)
- Forward link: 25 kbit/s to 100 kbit/s
- Return link: 53 kbit/s to 848 kbit/s

2.2 Key benefits

- High sensitivity provides long read range
- Highly advanced anti-collision resulting in highest identification speed
- Reliable and robust RFID technology suitable noisy environments and dense label populations

2.3 Custom features

• EAS

Enables the HF RFID tag to be used as EAS tag without the need for a backend data base.

3 Applications

- Healthcare and pharmaceutical supply chain
- Medical lab automation
- Document tracking
- · Casino chips
- Laundry automation

4 Ordering information

Type number	Package		
	Name	Description	Version
SL2S1402FUD	Wafer	sawn, bumped wafer, 120 μm, on film frame carrier, C _i between LA and LB = 0 pF (typical)	-
SL2S1402FUF	Wafer	sawn, bumped wafer, 75 μ m, on film frame carrier, C _i between LA and LB = 0 pF (typical)	-
SL2S1502FUD	Wafer	sawn, bumped wafer, 120 μm, on film frame carrier, C _i between LA and LB = 23.5 pF (typical)	-
SL2S1502FUF	Wafer	sawn, bumped wafer, 75 μ m, on film frame carrier, C _i between LA and LB = 23.5 pF (typical)	-
SL2S1602FUD	Wafer	sawn, bumped wafer, 120 μm, on film frame carrier, C _i between LA and LB = 97 pF (typical)	-
SL2S1502FTB	XSON3	plastic extremely thin small outline package; no leads; 3 terminals; body 1 x 1.45 x 0.5 mm; C_i between LA and LB = 23.5 pF (typical)	SOT1122

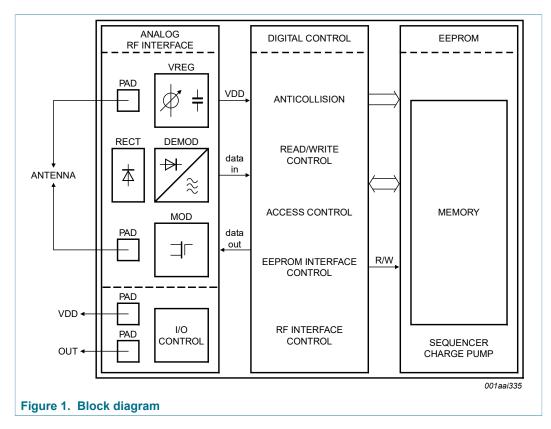
5 Block diagram

The SL2S1402; SL2S1502; SL2S1602 IC consists of three major blocks:

- Analog RF Interface
- Digital Controller
- EEPROM

The analog part provides stable supply voltage and demodulates data received from the reader for being processed by the digital part. Further, the modulation transistor of the analog part transmits data back to the reader.

The digital section includes the state machines, processes the protocol and handles communication with the EEPROM, which contains the EPC and the user data.



ICODE ILT

6 **Pinning information**

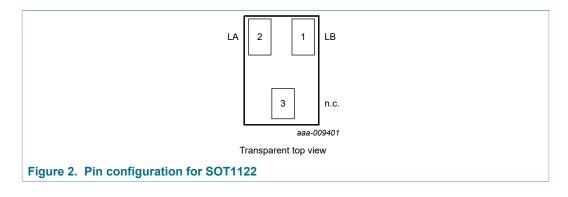
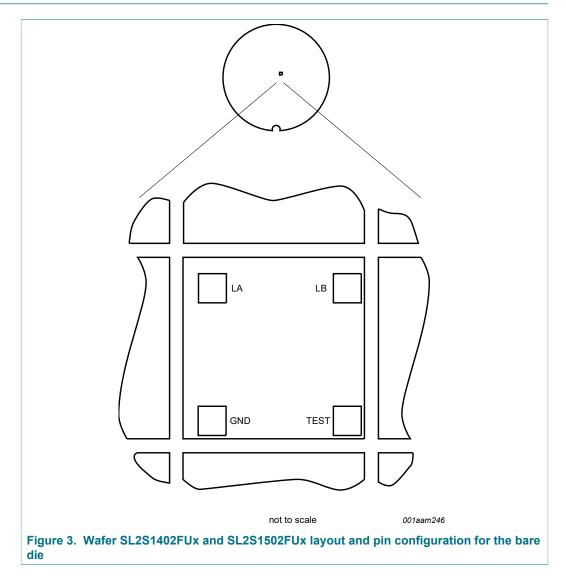


Table 2. Pin description SOT1122

Pin	Symbol	Description
1	LB	antenna RF input
2	LA	antenna RF input
3	n.c.	not connected

ICODE ILT

7 Wafer layout



ICODE ILT

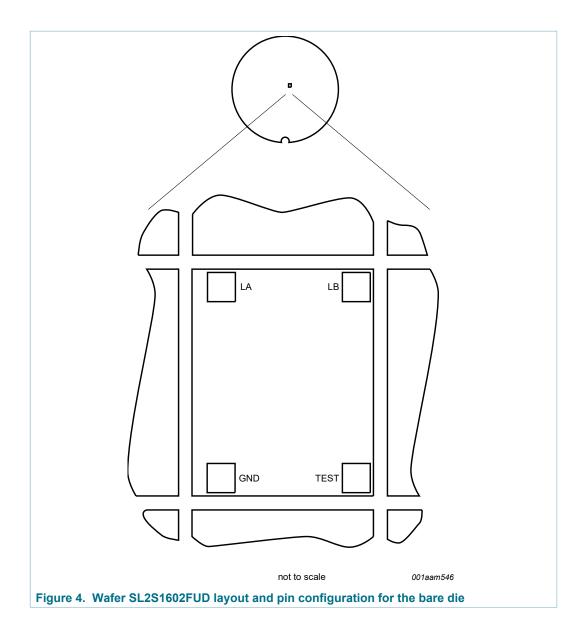


Table 3. Bond pad description

Tuble 0. Bolla pac	
Symbol	Description
LA	antenna RF input
LB	antenna RF input
GND	ground
TEST	test input

SL2S1402_SL2S1502_SL2S1602

8 Mechanical specification

8.1 Wafer specification

See <u>Ref. 13 "General specification for 8" wafer on UV-tape with electronic fail die</u> <u>marking"</u>.

Table 4. Wafer specification Wafer	
	each wafer is inscribed with batch number and wafer number
Designation	
Diameter	200 mm (8 inches)
Thickness	
SL2S1402FUD/ SL2S1502FUD/ SL2S1602FUD	120 μm ± 15 μm
SL2S1402FUF/SL2S1502FUF	75 μm ± 15 μm
Process	CMOS 0.14 µm
Batch size	25 wafers
Dies per wafer	
SL2S1402FUx/SL2S1502FUx	110050
SL2S1602FUD	88225
Wafer backside	
Material	Si
Treatment	ground and stress release
Roughness	R_a minimum = 0.5 μ m
	R _t maximum = 5 μm
Chip dimensions	
Die size without scribe	
SL2S1402FUx/SL2S1502FUx	520 μm × 484 μm = 251680 μm ²
SL2S1602FUD	520 μm × 607 μm = 315640 μm ²
Scribe line width	
X-dimension	15 μm (scribe line width measured between nitride edges)
Y-dimension	15 μm (scribe line width measured between nitride edges)
Number of pads	4
Pad location	non-diagonal/placed in chip corners
Distance pad to pad LA to LB	400 µm
Distance pad to pad LB to TEST	
SL2S1402FUx/SL2S1502FUx	360 µm
· · · · · · · · · · · · · · · · · · ·	
SL2S1602FUD	517 μm

Table 4. Wafer specification

SL2S1402_SL2S1502_SL2S1602

All information provided in this document is subject to legal disclaimers.

Туре	sandwich structure
Material	PE-nitride (on top)
Thickness	1.75 µm total thickness of passivation
Au bump	
Material	>99.9 % pure Au
Hardness	35 HV to 80 HV 0.005
Shear strength	>70 MPa
Height	18 μm
Height uniformity	
within a die	±2 μm
within a wafer	±3 μm
wafer to wafer	±4 μm
Bump flatness	±1.5 μm
Bump size	
LA, LB	60 μm × 60 μm
TEST, GND	60 μm × 60 μm
variation	±5 μm
Under bump metallization	sputtered TiW

8.1.1 Fail die identification

No inkdots are applied to the wafer.

Electronic wafer mapping (SECS II format) covers the electrical test results and additionally the results of mechanical/visual inspection.

See <u>Ref. 13 "General specification for 8" wafer on UV-tape with electronic fail die</u> <u>marking"</u>

8.1.2 Map file distribution

See <u>Ref. 13 "General specification for 8" wafer on UV-tape with electronic fail die</u> <u>marking"</u>.

9 Functional description

9.1 Power transfer

Whenever connected to a very simple and cheap type of antenna (as a result of the 13.56 MHz carrier frequency) made out of a few windings printed, winded, etched or punched coil the ICODE ILT IC can be operated without line of sight up to a distance of 1.5 m (gate width). No battery is needed.

9.2 Data transfer

9.2.1 Reader to tag Link

An interrogator transmits information to the ICODE ILT by modulating an RF signal in the 13.56 MHz frequency. The ICODE ILT receives both information and operating energy from this RF signal. Tags are passive, meaning that they receive all of their operating energy from the interrogator's RF waveform.

An interrogator is using a fixed modulation and data rate for the duration of at least an inventory round. It communicates to the ICODE ILT by modulating an RF carrier using DSB-ASK with PIE encoding.

For further details refer to <u>Section 18, Ref. 2</u>. Interrogator-to-tag (R=>T) communications.

9.2.2 Tag to reader Link

An interrogator receives information from the ICODE ILT by transmitting a continuouswave RF signal to the tag; the ICODE ILT responds by load modulation of the 13.56 MHz carrier frequency, thereby generating modulated sidebands used to transmit an information signal to the interrogator. The system is a reader talks first (RTF) system, meaning that a ICODE ILT only responds with an information signal after being directed by the interrogator.

ICODE ILT transmits information using ASK modulation. The returned data are either coded with FM0 baseband, Miller with sub carrier or Manchester with sub carrier. The interrogator can select if the ICODE ILT shall respond with a sub carrier frequency of 424 kHz or 848 kHz.

For further details refer to Section 18, Ref. 2. tag-to-interrogator (T=>R) communications.

9.3 Air interface standards

The ICODE ILT fully supports all parts of the ISO 18000-3 Mode 3 (refer to <u>Section 18</u>, <u>Ref. 1</u>) and the "EPC[™] Radio-Frequency Identity Protocols EPC Class-1 HF RFID Air Interface Protocol for Communications at 13.56 MHz, Version 2.0.3" (refer to <u>Section 18</u>, <u>Ref. 2</u>).

10 Memory configuration

This section contains all information including commands by which a reader selects, inventories, and accesses a ICODE ILT population

An interrogator manages ICODE ILT equipped tag populations using three basic operations. Each of these operations comprises one or more commands. The operations are defined as follows:

Table 5. Tag populations

Operation	Description
Select:	The process by which an interrogator selects a tag population for inventory and access. Interrogators may use one or more Select commands to select a particular tag population prior to inventory.
Inventory:	The process by which an interrogator identifies ICODE ILT equipped tags. An interrogator begins an inventory round by transmitting a BeginRound command in one of two sessions. One or more tags may reply. The interrogator detects a single tag reply and requests the PC, EPC, and CRC-16 from the chip. An inventory round operates in one and only one session at a time. For an example of an interrogator inventorying and accessing a single tag refer to <u>Section 18</u> , <u>Ref. 2</u> .
Access:	The process by which an interrogator transacts with (reads from or writes to) individual tags. An individual tag must be uniquely identified prior to access. Access comprises multiple commands, some of which employ one-time-pad based cover-coding of the R=>T link.

10.1 Memory

For the general memory layout according to the standard <u>Section 18</u>, <u>Ref. 2</u>. The tag memory is logically subdivided into four distinct banks.

In accordance to the standard <u>Section 18</u>, <u>Ref. 2</u>. The tag memory of the ICODE ILT is organized in following 4 memory sections:

Table 6. Memory sections									
Name	Size	Bank							
Reserved memory (32-bit ACCESS and 32-bit KILL password)	64 bit	00b							
EPC (excluding 16 bit CRC-16 and 16-bit PC)	240 bit	01b							
TID (including unique 48 bit serial number)	96 bit	10b							

The logical address of all memory banks begin at zero (00h).

ICODE ILT

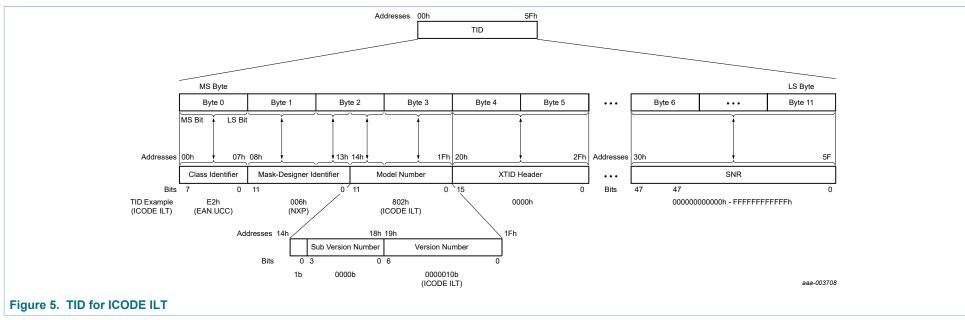


Table 7. Model number

	SI (Status Indicator Bit)	Sub Version No.	Version (Silicon) No.
ICODE ILT	1	0000b	0000010b

10.1.1 Memory map

Bank address	Memory address	Туре	Content	Initial ^[1]	Remark
Bank 00	00h – 1Fh	Reserved	kill password: refer to <u>Section 18, Ref. 2</u>	all 00h	unlocked memory
	20h – 3Fh	Reserved	access password: refer to <u>Section 18</u> , <u>Ref. 2</u>	all 00h	unlocked memory
Bank 01	00h – 0Fh	EPC	CRC-16: refer to <u>Section 18</u> , <u>Ref. 2</u>		memory mapped calculated CRC
	10h – 14h	EPC	Backscatter length: refer to <u>Section 18</u> , <u>Ref. 2</u>	00110b	unlocked memory
	15h	EPC	UMI refer to <u>Section 18, Ref. 2</u>	0b	unlocked memory
	16h	EPC	XI: refer to Section 18, Ref. 2	Ob	calculated
	17h –1Fh	EPC	Numbering system indicator: refer to <u>Section 18, Ref. 2</u>	00h	unlocked memory
	20h - 10Fh	EPC	EPC: refer to <u>Section 18, Ref. 2</u>		unlocked memory
	110h - 1FFh	EPC	RFU	0000h	factory locked memory
	200h - 20Fh	EPC	ConfigWord	0000h	unlocked memory
	210h - 21Fh	EPC	XPC_W1	0000h	factory locked memory
Bank 10	00h – 07h	TID	allocation class identifier: refer to <u>Section 18</u> , <u>Ref. 2</u>	1110 0010b	factory locked memory
	08h – 13h	TID	tag mask designer identifier: refer to <u>Section 18</u> , <u>Ref. 2</u>	0000 0000 0110b	factory locked memory
	14h – 1Fh	TID	tag model number: refer to <u>Section 18, Ref. 2</u>	TMNR	factory locked memory
	20h – 2Fh	TID	Extended TID header refer to [Section 18, Ref. 3	XTID Header	locked memory
	30h – 5Fh	TID	serial number: refer to [<u>Section 18</u> , <u>Ref. 2</u>	SNR	locked memory

[1] This is the initial memory content when delivered by NXP Semiconductors

10.1.1.1 Supported EPC types

The EPC types are defined in the EPC Tag Standards document from EPCglobal.

These standards define completely that portion of EPC tag data that is standardized, including how that data is encoded on the EPC tag itself (i.e. the EPC Tag Encodings),

SL2S1402_SL2S1502_SL2S1602
Product data sheet
COMPANY PUBLIC

as well as how it is encoded for use in the information systems layers of the EPC Systems Network (i.e. the EPC URI or Uniform Resource Identifier Encodings).

The EPC Tag Encodings include a Header field followed by one or more Value Fields. The Header field indicates the length of the Values Fields and contains a numbering system identifier (NSI). The Value Fields contain a unique EPC Identifier and optional Filter Value when the latter is judged to be important to encode on the tag itself.

SL2S1402_SL2S1502_SL2S1602

ICODE ILT

11 Interrogator commands and tag replies

For a detailed description refer to <u>Section 18</u>, <u>Ref. 2</u>.

11.1 Commands

An overview of interrogator to tag commands is located in Section 18, Ref. 2.

Note that all mandatory commands are implemented on the ICODE ILT according to the standard. Additionally the optional command Access is supported by the ICODE ILT IC (for details refer to <u>Section 11.5 "Optional Access Command"</u>). Besides also custom commands are implemented on the ICODE ILT IC (for details refer to <u>Section 11.7 "Custom Commands"</u>.

11.2 Mandatory Select Commands

Select commands select a particular ICODE ILT tag population based on user-defined criteria.

11.2.1 Select

For a detailed description of the mandatory Select command refer to Section 18, Ref. 2.

11.3 Mandatory Inventory Commands

Inventory commands are used to run the collision arbitration protocol.

11.3.1 BeginRound

For a detailed description of the mandatory BeginRound command refer to <u>Section 18</u>, <u>Ref. 2</u>.

11.3.2 AdjustRound

For a detailed description of the mandatory AdjustRound command refer to <u>Section 18</u>, <u>Ref. 2</u>.

11.3.3 NextSlot

For a detailed description of the mandatory NextSlot command refer to <u>Section 18</u>, <u>Ref.</u> $\underline{2}$.

11.3.4 ACK

For a detailed description of the mandatory ACK command refer to Section 18, Ref. 2.

11.3.5 NAK

For a detailed description of the mandatory NAK command refer to Section 18, Ref. 2.

COMPANY PUBLIC

ICODE ILT

11.4 Mandatory Access Commands

Access commands are used to read or write data from or to the ICODE ILT memory. For a detailed description of the mandatory Access command refer to <u>Section 18</u>, <u>Ref. 2</u>.

11.4.1 REQ_RN

Access commands are used to read or write data from or to the ICODE ILT memory. For a detailed description of the mandatory Access command refer to <u>Section 18</u>, <u>Ref. 2</u>.

11.4.2 READ

For a detailed description of the mandatory Req_RN command refer to <u>Section 18</u>, <u>Ref.</u> <u>2</u>.

11.4.3 WRITE

For a detailed description of the mandatory Write command refer to Section 18, Ref. 2.

11.4.4 KILL (RECOMMISSIONING)

Only mandatory asserted Recom bit 3SB is supported.

For a detailed description of the mandatory Kill command refer to Section 18, Ref. 2.

11.4.5 LOCK

For a detailed description of the mandatory Lock command refer to Section 18, Ref. 2.

11.5 Optional Access Command

11.5.1 Access

For a detailed description of the optional Access command refer to <u>Section 18</u>, <u>Ref. 2</u>, section 6.3.2.10.

11.5.2 BlockWrite

The BlockWrite command supports the writing of up to two data words at once (WordCount = 00h to 02h). For a detailed description of the optional BlockWrite command refer to <u>Section 18</u>, <u>Ref. 2</u>.

11.6 Optional Features

11.6.1 UMI

The UMI (User Memory Indicator bit 15h) of the Protocol-control (PC) word is supported using Method 2 (written by the reader). For a detailed description of the optional UMI bit refer to <u>Section 18</u>, <u>Ref. 2</u>.

11.7 Custom Commands

SL2S1402_SL2S1502_SL2S1602 Product data sheet COMPANY PUBLIC

11.7.1 ChangeConfigWord

The ConfigWord is located in the EPC Memory Bank at the memory address 200h - 20Fh. Dedicated bits in this word control the custom-specific feature EAS. Memory is accessible with Select and Read sequence.

The ChangeConfigWord command allows to read the dedicated bits in open and secured state. Changing these dedicated bits is only possible if the access password is not equal zero and the IC is in the secured state.

Table 9. ConfigWord

Bank address	Memory address	Туре	Initial	Remark
Bank 01 (EPC)	200h - 20Eh	RFU	0b	
	20Fh	EAS Alarm bit	0b	

Table 10. ConfigWord details

MSB															LSB
200 hex	201 hex	202 hex	203 hex	204 hex	205 hex	206 hex	207 hex	208 hex	209 hex	20A hex	20B hex	20C hex	20D hex	20E hex	20F hex
RFU	EAS alarm bit														

Table 11. Command coding

	Command	RFU	Data	RN	CRC-16
No. of bits	16	8	16	16	16
Description	11100000 00000111	0000 0000	Toggle EAS Bit optionally XOR RN16	handle	

After completing a successful ChangeConfigWord command the ICODE ILT backscatters the reply within 20 ms shown below comprising a header (a 0-bit), the ConfigWord, the handle, and a CRC-16 calculated over the 0-bit, ConfigWord and handle.

Table 12. ChangeConfigWord command response

	Header	Status bits	RN	CRC-16
No. of bits	1	16	16	16
Description	0	ConfigWord	handle	

If the toggle bits are transmitted with a value of 00h the ICODE ILT responds with a successful Change ConfigWord reply (i.e. the ConfigWord) which allows to read the actual ConfigWord content.

If the ICODE ILT encounters an error during execution of ChangeConfigWord it backscatters an error code (see <u>Section 18</u>, <u>Ref. 2</u> for error-code definitions and for the reply format).

Starting state	Condition	Response	Next state
ready	all	-	ready
arbitrate, reply, acknowledged	all	-	arbitrate
open	valid handle, ConfigWord needs to change	Backscatter unchanged ConfigWord immediately	open
	valid handle, ConfigWord does not need to change	Backscatter ConfigWord immediately	open
secured	valid handle, ConfigWord needs to change	Backscatter modified ConfigWord, when done	secured
	valid handle, ConfigWord does not need to change	Backscatter ConfigWord immediately	secured
	invalid handle	-	secured
killed	all	-	killed

11.8 Custom features

11.8.1 EAS

The ICODE ILT offers an EAS feature which can be enabled or disabled with the ChangeConfigWord command by toggling the EAS Alarm bit.

Only tags with the EAS Alarm bit set to 1 will respond to the following command sequence (inventory round) with their EPC:

- Select command to the EAS Alarm bit with the parameters MemBank: 01h (EPC) Action: 010b (deassert SL if not matching) Pointer: 20Fh Mask length: 01h Mask: 1b
- 2. BeginRound
- 3. ACK

11.8.2 FastInitialWrite

If the memory content where data shall be written is completely 00h the write command will be executed within shorter time. The FastInitialWrite is internally executed for all commands where the memory content is changed (e.g. Write, Lock, BlockWrite, BlockPermalock,...).

12 Limiting values

Table 14. Limiting values (Wafer)^{[1][2]}

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Мах	Unit
T _{stg}	storage temperature			-55	+125	°C
P _{tot}	total power dissipation			-	125	mW
Tj	junction temperature			-40	+85	°C
I _{i(max)}	maximum input current	LA to LB; peak	[3]	-	±60	mA
lı	input current	LA to LB; RMS		-	30	mA
V _{ESD}	electrostatic discharge voltage	Human body model	[4] [5]	-	±2	kV

 Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any conditions other than those described in the operating conditions and electrical characteristics sections of this specification is not implied.

[2] This product includes circuitry specifically designed for the protection of its internal devices from the damaging effects of excessive static charge.

Nonetheless, it is suggested that conventional precautions be taken to avoid applying greater than the rated maxima.

[3] The voltage between LA and LB is limited by the on-chip voltage limitation circuitry (corresponding to parameter I₁).

[4] For ESD measurement, the IC was mounted in a CDIP8 package.

[5] HBM: ANSI/ESDA/JEDEC JS-001

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices. Such precautions are described in the *ANSI/ESD S20.20, IEC/ST 61340-5, JESD625-A* or equivalent standards.

13 Characteristics

13.1 Memory characteristics

Table 15. EEPROM characteristics							
Symbol	Parameter	Conditions	Min	Тур	Мах	Unit	
t _{ret}	retention time	T _{amb} ≤ 55 °C	50	-	-	year	
N _{endu(W)}	write endurance		100000	-	-	cycle	

13.2 Interface characteristics

Table 16. Interface characteristics

Typical ratings are not guaranteed. The values listed are at room temperature.

Symbol	Parameter	Conditions		Min	Тур	Мах	Unit
f _i	input frequency		[1]	13.553	13.56	13.567	MHz
V _{i(RMS)min}	minimum RMS input voltage	operating read/write		1.5	-	1.7	V
P _{i(min)}	minimum input power	operating	[2]	-	40	-	μW
C _i	input capacitance	between LA and LB	[3]				
		SL2S1402FUx		-	-	-	pF
		SL2S1502FUx		22.3	23.5	24.7	pF
		SL2S1602FUD		92	97	102	pF

Bandwidth limitation (\pm 7 kHz) according to ISM band regulations. Including losses in the resonant capacitor and rectifier. Measured with an HP4285A LCR meter at 13.56 MHz and 2 V RMS. [1] [2] [3]

SL2S1402_SL2S1502_SL2S1602

14 Marking

14.1 Marking SOT1122

Table 17. Marking SOT1122

Type number	Marking code
SL2S1502FTB	S0

15 Package outline

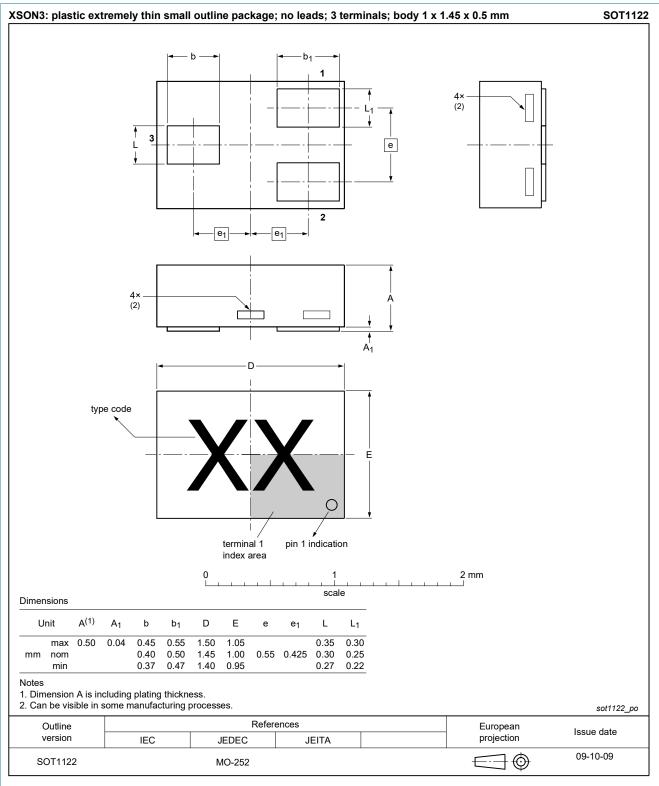
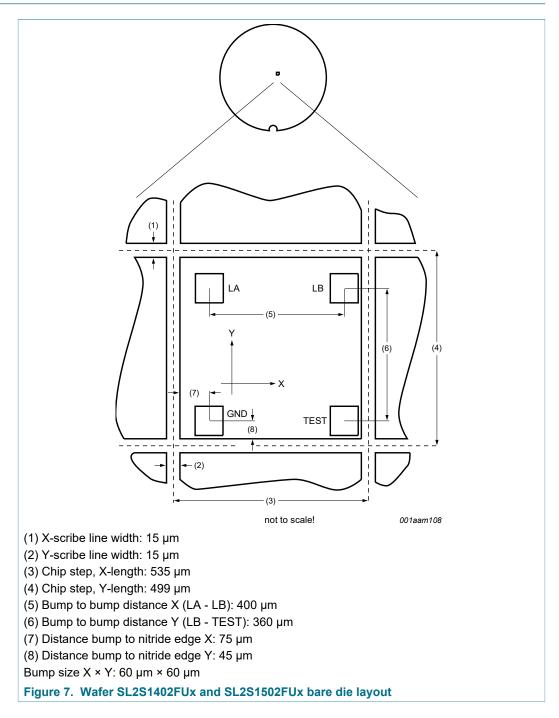


Figure 6. Package outline SOT1122

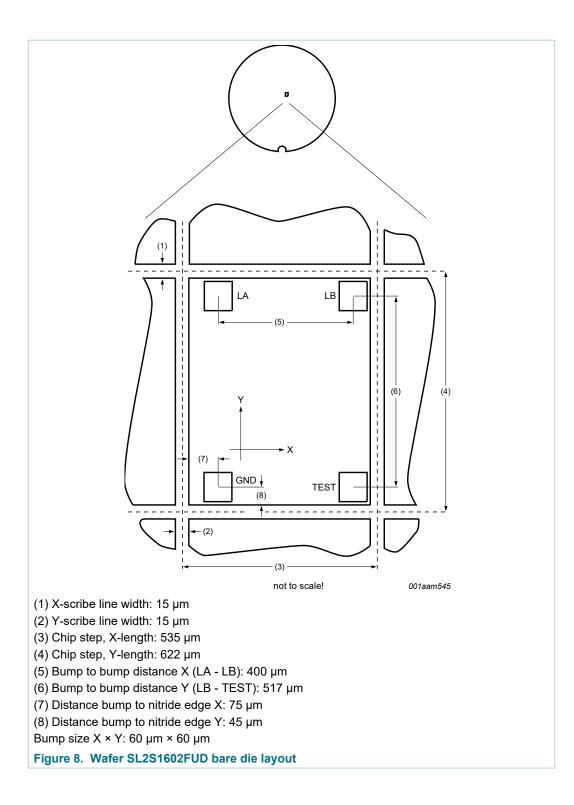
SL2S1402_SL2S1502_SL2S1602 Product data sheet COMPANY PUBLIC

ICODE ILT

16 Bare die outline



ICODE ILT



ICODE ILT

17 Abbreviations

Table 18. Abbr	reviations
Acronym	Description
CRC	Cyclic redundancy check
CW	Continuous wave
EEPROM	Electrically Erasable Programmable Read Only Memory
EPC	Electronic Product Code (containing Header, Domain Manager, Object Class and Serial Number)
FM0	Bi phase space modulation
IC	Integrated Circuit
LSB	Least Significant Byte/Bit
MSB	Most Significant Byte/Bit
NRZ	Non-Return to Zero coding
RF	Radio Frequency
RTF	Reader Talks First
Tari	Type A Reference Interval (ISO 18000-3 mode 3/EPC Class-1 HF)
HF	High Frequency
XX _b	Value in binary notation
xx _{hex}	Value in hexadecimal notation

18 References

- 1. ISO 18000-3M3
- 2. EPC[™] Radio-Frequency Identity Protocols EPC Class-1 HF RFID Air Interface Protocol for Communications at 13.56 MHz, Version 2.0.3
- 3. EPCglobal: EPC Tag Data Standards 1.5
- 4. ECC ERC Recommendation 70-03 Annex 9
- 5. ISO/IEC Directives, Part 2: Rules for the structure and drafting of International Standards
- ISO/IEC 3309: Information technology Telecommunications and information exchange between systems – High-level data link control (HDLC) procedures – Frame structure
- ISO/IEC 15961: Information technology, Automatic identification and data capture

 Radio frequency identification (RFID) for item management Data protocol:
 application interface
- 8. ISO/IEC 15962: Information technology, Automatic identification and data capture techniques Radio frequency identification (RFID) for item management Data protocol: data encoding rules and logical memory functions
- 9. ISO/IEC 15963: Information technology Radio frequency identification for item management — Unique identification for RF tags
- 10.ISO/IEC 18000-1: Information technology Radio frequency identification for item management — Part 1: Reference architecture and definition of parameters to be standardized
- 11.ISO/IEC 19762: Information technology AIDC techniques Harmonized vocabulary Part 3: radio-frequency identification (RFID)
- 12.U.S. Code of Federal Regulations (CFR), Title 47, Chapter I, Part 15: Radio-frequency devices, U.S. Federal Communications Commission

[13]

General specification for 8" wafer on UV-tape with electronic fail die marking, Delivery type description – BU-ID document number: 1093**¹.

^{1 ** ...} document version number

19 Revision history

Table 19. Revision history						
Document ID	Release date	Data sheet status	Supersedes			
SL2S1402_SL2S1502_SL2S1602 v. 3.3	20191015	Product data sheet	SL2S1402_SL2S1502_SL2S1602 v. 3.2			
Modifications:	 75 µ wafer thickness delivery types SL2S1402FUF and SL2S1502FUF in <u>Section 4</u> <u>"Ordering Information"</u> and <u>Section 8.1 "Wafer specification"</u> added 					
SL2S1402_SL2S1502_SL2S1602 v. 3.2	20131008	Product data sheet	SL2S1402_SL2S1502_SL2S1602 v. 3.1			
Modifications:	Type SL2S1 <u>Section 14 "I</u>	502FTB added Marking" and <u>Section 15 "Packag</u> u	<u>e outline"</u> : added			
SL2S1402_SL2S1502_SL2S1602 v. 3.1	20130923	Product data sheet	SL2S1402_SL2S1502_SL2S1602 v. 3.0			
Modifications:	Security status changed into COMPANY PUBLIC					
SL2S1402_SL2S1502_SL2S1602 v. 3.0	20120522	Product data sheet	-			

20 Legal information

20.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

Please consult the most recently issued document before initiating or completing a design. [1]

[2] [3] The term 'short data sheet' is explained in section "Definitions".

The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

20.2 Definitions

Draft — The document is a draft version only. The content is still under internal review and subject to formal approval, which may result in modifications or additions. NXP Semiconductors does not give any representations or warranties as to the accuracy or completeness of information included herein and shall have no liability for the consequences of use of such information

Short data sheet — A short data sheet is an extract from a full data sheet with the same product type number(s) and title. A short data sheet is intended for quick reference only and should not be relied upon to contain detailed and full information. For detailed and full information see the relevant full data sheet, which is available on request via the local NXP Semiconductors sales office. In case of any inconsistency or conflict with the short data sheet, the full data sheet shall prevail.

Product specification — The information and data provided in a Product data sheet shall define the specification of the product as agreed between NXP Semiconductors and its customer, unless NXP Semiconductors and customer have explicitly agreed otherwise in writing. In no event however, shall an agreement be valid in which the NXP Semiconductors product is deemed to offer functions and qualities beyond those described in the Product data sheet.

20.3 Disclaimers

Limited warranty and liability - Information in this document is believed to be accurate and reliable. However, NXP Semiconductors does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information. NXP Semiconductors takes no responsibility for the content in this document if provided by an information source outside of NXP Semiconductors. In no event shall NXP Semiconductors be liable for any indirect, incidental, punitive, special or consequential damages (including - without limitation - lost profits, lost savings, business interruption, costs related to the removal or replacement of any products or rework charges) whether or not such damages are based on tort (including negligence), warranty, breach of contract or any other legal theory. Notwithstanding any damages that customer might incur for any reason whatsoever, NXP Semiconductors' aggregate and cumulative liability towards customer for the products described herein shall be limited in accordance with the Terms and conditions of commercial sale of NXP Semiconductors

Right to make changes - NXP Semiconductors reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without

notice. This document supersedes and replaces all information supplied prior to the publication hereof.

Suitability for use — NXP Semiconductors products are not designed, authorized or warranted to be suitable for use in life support, life-critical or safety-critical systems or equipment, nor in applications where failure or malfunction of an NXP Semiconductors product can reasonably be expected to result in personal injury, death or severe property or environmental damage. NXP Semiconductors and its suppliers accept no liability for inclusion and/or use of NXP Semiconductors products in such equipment or applications and therefore such inclusion and/or use is at the customer's own risk

 $\ensuremath{\mathsf{Applications}}$ — Applications that are described herein for any of these products are for illustrative purposes only. NXP Semiconductors makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification. Customers are responsible for the design and operation of their applications and products using NXP Semiconductors products, and NXP Semiconductors accepts no liability for any assistance with applications or customer product design. It is customer's sole responsibility to determine whether the NXP Semiconductors product is suitable and fit for the customer's applications and products planned, as well as for the planned application and use of customer's third party customer(s). Customers should provide appropriate design and operating safeguards to minimize the risks associated with their applications and products. NXP Semiconductors does not accept any liability related to any default, damage, costs or problem which is based on any weakness or default in the customer's applications or products, or the application or use by customer's third party customer(s). Customer is responsible for doing all necessary testing for the customer's applications and products using NXP Semiconductors products in order to avoid a default of the applications and the products or of the application or use by customer's third party customer(s). NXP does not accept any liability in this respect

Limiting values - Stress above one or more limiting values (as defined in the Absolute Maximum Ratings System of IEC 60134) will cause permanent damage to the device. Limiting values are stress ratings only and (proper) operation of the device at these or any other conditions above those given in the Recommended operating conditions section (if present) or the Characteristics sections of this document is not warranted. Constant or repeated exposure to limiting values will permanently and irreversibly affect the quality and reliability of the device.

Terms and conditions of commercial sale - NXP Semiconductors products are sold subject to the general terms and conditions of commercial sale, as published at http://www.nxp.com/profile/terms, unless otherwise agreed in a valid written individual agreement. In case an individual agreement is concluded only the terms and conditions of the respective agreement shall apply. NXP Semiconductors hereby expressly objects to applying the customer's general terms and conditions with regard to the purchase of NXP Semiconductors products by customer.

SL2S1402_SL2S1502_SL2S1602

Product data sheet COMPANY PUBLIC All information provided in this document is subject to legal disclaimers. Rev. 3.3 - 15 October 2019 234333

© NXP B.V. 2019. All rights reserved

ICODE ILT

No offer to sell or license — Nothing in this document may be interpreted or construed as an offer to sell products that is open for acceptance or the grant, conveyance or implication of any license under any copyrights, patents or other industrial or intellectual property rights.

Quick reference data — The Quick reference data is an extract of the product data given in the Limiting values and Characteristics sections of this document, and as such is not complete, exhaustive or legally binding.

Export control — This document as well as the item(s) described herein may be subject to export control regulations. Export might require a prior authorization from competent authorities.

Non-automotive qualified products — Unless this data sheet expressly states that this specific NXP Semiconductors product is automotive qualified, the product is not suitable for automotive use. It is neither qualified nor tested in accordance with automotive testing or application requirements. NXP Semiconductors accepts no liability for inclusion and/or use of non-automotive qualified products in automotive equipment or applications. In the event that customer uses the product for design-in and use in automotive applications to automotive specifications and standards, customer (a) shall use the product without NXP Semiconductors' warranty of the product for such automotive applications, use and specifications, and (b) whenever customer uses the product for automotive applications beyond NXP Semiconductors' specifications such use shall be solely at customer's own

risk, and (c) customer fully indemnifies NXP Semiconductors for any liability, damages or failed product claims resulting from customer design and use of the product for automotive applications beyond NXP Semiconductors' standard warranty and NXP Semiconductors' product specifications.

Translations — A non-English (translated) version of a document is for reference only. The English version shall prevail in case of any discrepancy between the translated and English versions.

Security — While NXP Semiconductors has implemented advanced security features, all products may be subject to unidentified vulnerabilities. Customers are responsible for the design and operation of their applications and products to reduce the effect of these vulnerabilities on customer's applications and products, and NXP Semiconductors accepts no liability for any vulnerability that is discovered. Customers should implement appropriate design and operating safeguards to minimize the risks associated with their applications and products.

20.4 Trademarks

Notice: All referenced brands, product names, service names and trademarks are the property of their respective owners.

ICODE and I-CODE — are trademarks of NXP B.V.

SL2S1402_SL2S1502_SL2S1602

NXP Semiconductors

SL2S1402_SL2S1502_SL2S1602

Tables

Ordering information	4
Pin description SOT1122	6
Bond pad description	8
Wafer specification	9
Tag populations	12
Memory sections	12
Model number	14
Memory map	14
ConfigWord	18
ConfigWord details	18
	Pin description SOT1122 Bond pad description Wafer specification Tag populations Memory sections Model number Memory map ConfigWord

Tab. 11.	Command coding	18
Tab. 12.	ChangeConfigWord command response .	18
Tab. 13.	Command response table	19
Tab. 14.	Limiting values (Wafer)	20
	EEPROM characteristics	
Tab. 16.	Interface characteristics	21
Tab. 17.	Marking SOT1122	
Tab. 18.	Abbreviations	26
Tab. 19.	Revision history	28

Figures

Fig. 1.	Block diagram5	
Fig. 2.	Pin configuration for SOT11226	
Fig. 3.	Wafer SL2S1402FUx and SL2S1502FUx	
	layout and pin configuration for the bare die7	
Fig. 4.	Wafer SL2S1602FUD layout and pin	
	configuration for the bare die8	

Fig. 5.	TID for ICODE ILT	13
Fig. 6.	Package outline SOT1122	23
Fig. 7.	Wafer SL2S1402FUx and SL2S1502FUx	
	bare die layout	24
Fig. 8.	Wafer SL2S1602FUD bare die layout	25

Contents

1	General description1
2	Features and benefits2
2.1	Key features2
2.2	Key benefits2
2.3	Custom features2
3	Applications3
4	Ordering information4
5	Block diagram5
6	Pinning information6
7	Wafer layout7
8	Mechanical specification9
8.1	Wafer specification9
8.1.1	Fail die identification10
8.1.2	Map file distribution10
9	Functional description11
9.1	Power transfer
9.2	Data transfer11
9.2.1	Reader to tag Link11
9.2.2	Tag to reader Link11
9.3	Air interface standards11
10	Memory configuration 12
10.1	Memory
10.1.1	Memory map14
10.1.1.1	
11	Interrogator commands and tag replies
11.1	Commands
11.2	Mandatory Select Commands 16
11.2.1	Select
11.3	Mandatory Inventory Commands16
11.3.1	BeginRound16
11.3.2	AdjustRound16
11.3.3	NextSlot
11.3.4	ACK16
11.3.5	NAK16
11.4	Mandatory Access Commands17
11.4.1	REQ RN
11.4.2	READ
11.4.3	WRITE
11.4.4	KILL (RECOMMISSIONING)
11.4.5	LOCK
11.5	Optional Access Command17
11.5.1	Access
11.5.2	BlockWrite17
11.6	Optional Features17
11.6.1	UMI
11.7	Custom Commands17
11.7.1	ChangeConfigWord
11.8	Custom features
11.8.1	EAS
11.8.2	FastInitialWrite
12	Limiting values
13	Characteristics
13.1	Memory characteristics

13.2	Interface characteristics	21
14	Marking	22
14.1	Marking SOT1122	22
15	Package outline	23
16	Bare die outline	24
17	Abbreviations	
18	References	27
19	Revision history	
20	Legal information	

Please be aware that important notices concerning this document and the product(s) described herein, have been included in section 'Legal information'.

© NXP B.V. 2019.

All rights reserved.

For more information, please visit: http://www.nxp.com For sales office addresses, please send an email to: salesaddresses@nxp.com



Компания «ЭлектроПласт» предлагает заключение долгосрочных отношений при поставках импортных электронных компонентов на взаимовыгодных условиях!

Наши преимущества:

- Оперативные поставки широкого спектра электронных компонентов отечественного и импортного производства напрямую от производителей и с крупнейших мировых складов;
- Поставка более 17-ти миллионов наименований электронных компонентов;
- Поставка сложных, дефицитных, либо снятых с производства позиций;
- Оперативные сроки поставки под заказ (от 5 рабочих дней);
- Экспресс доставка в любую точку России;
- Техническая поддержка проекта, помощь в подборе аналогов, поставка прототипов;
- Система менеджмента качества сертифицирована по Международному стандарту ISO 9001;
- Лицензия ФСБ на осуществление работ с использованием сведений, составляющих государственную тайну;
- Поставка специализированных компонентов (Xilinx, Altera, Analog Devices, Intersil, Interpoint, Microsemi, Aeroflex, Peregrine, Syfer, Eurofarad, Texas Instrument, Miteq, Cobham, E2V, MA-COM, Hittite, Mini-Circuits, General Dynamics и др.);

Помимо этого, одним из направлений компании «ЭлектроПласт» является направление «Источники питания». Мы предлагаем Вам помощь Конструкторского отдела:

- Подбор оптимального решения, техническое обоснование при выборе компонента;
- Подбор аналогов;
- Консультации по применению компонента;
- Поставка образцов и прототипов;
- Техническая поддержка проекта;
- Защита от снятия компонента с производства.



Как с нами связаться

Телефон: 8 (812) 309 58 32 (многоканальный) **Факс:** 8 (812) 320-02-42 **Электронная почта:** <u>org@eplast1.ru</u> **Адрес:** 198099, г. Санкт-Петербург, ул. Калинина, дом 2, корпус 4, литера А.